

Search Notes



Application/Control No.

10/808,632

Examiner

Tae H. Yoon

Applicant(s)/Patent under Reexamination

TUNG ET AL.

Art Unit

1714

SEARCHED

Class	Subclass	Date	Examiner
524	439	11-28-06	zy
	440		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
524	439	5/13/07	zy

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EASP Inventor Search	11-28-06	zy